

## P-Channel 100-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)			
- 100	0.160 at V <sub>GS</sub> = - 10 V	- 2.5 <sup>c</sup>	23.2 nC			
	0.200 at V <sub>GS</sub> = - 4.5 V	- 2.3 <sup>c</sup>	23.2 110			

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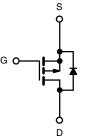
### **FEATURES**

- TrenchFET® Power MOSFET
- 100% R<sub>q</sub> and UIS Tested



#### **APPLICATIONS**

- Active Clamp in Intermediate DC/ DC Power Supplies
- H-Bridge High Side Switch for Lighting Application



P-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	$V_{DS}$	- 100	V		
Gate-Source Voltage	V <sub>GS</sub>	± 20	V		
	T <sub>C</sub> = 25 °C		- 2.5		
Continuous Drain Current /T 150 °C)	T <sub>C</sub> = 70 °C	1 ,	- 2.3		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	l <sub>D</sub>	- 2 <sup>a, b</sup>		
	T <sub>A</sub> = 70 °C		- 1.6 <sup>a, b</sup>		
Pulsed Drain Current	I <sub>DM</sub>	- 15	Α		
Continuous Course Dusin Diada Courset	T <sub>C</sub> = 25 °C		- 4.9		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	- I <sub>S</sub>	- 2.5 <sup>a, b</sup>		
Avalanche Current	1 0.1 ml l	I <sub>AS</sub>	- 15		
Single-Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	11.25	mJ	
	T <sub>C</sub> = 25 °C		5.9	14/	
Maniana Paula Dissination	T <sub>C</sub> = 70 °C		3.8		
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	3.1 <sup>a, b</sup>	W	
	T <sub>A</sub> = 70 °C		2 <sup>a, b</sup>		
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stq</sub>	- 55 to 150	°C		

#### Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Based on  $T_C$  = 25 °C.

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>a, b</sup>	t ≤ 10 s	R <sub>thJA</sub>	33	40	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	17	21	C/VV	

#### Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. Maximum under steady state conditions is 80  $^{\circ}\text{C/W}.$

服务热线:400-655-8788

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static				•		
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 100			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = - 250 μA		- 165		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	η = - 250 μΑ		- 6.6		mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 3	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zava Cata Valtaga Dvain Curvent	I <sub>DSS</sub>	V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V			- 1	
Zero Gate Voltage Drain Current		V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10	μA
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 8			Α
	D	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 2 A		0.160		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5V, I <sub>D</sub> = - 1.5 A		0.200		Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = 2 A		12		S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>			1190		pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		61		
Reverse Transfer Capacitance	C <sub>rss</sub>			42		
Tatal Oats Observe	Q <sub>g</sub> —	$V_{DS} = -50 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -2 \text{ A}$		27.5	42	
Total Gate Charge				23.2	35	~C
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -50 \text{ V}, V_{GS} = -6 \text{ V}, I_{D} = -2 \text{ A}$		5.4		nC
Gate-Drain Charge	Q <sub>gd</sub>			8.4		
Gate Resistance	$R_g$	f = 1 MHz		6.1	9.2	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			20	30	
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 75 V, $R_L$ = 25 $\Omega$		95	145	
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -3 \text{ A}, V_{GEN} = -6 \text{ V}, R_g = 1 \Omega$		38	60	
Fall Time	t <sub>f</sub>			34	51	no
Turn-On Delay Time	t <sub>d(on)</sub>			11	18	ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 75 V, $R_L$ = 25 $\Omega$		28	42	
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong$ - 2 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$		52	78	
Fall Time	t <sub>f</sub>			35	53	
<b>Drain-Source Body Diode Characterist</b>	ics					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 13	۸
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 15	Α
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = - 2 A		- 0.8	- 1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			65	90	ns
Body Diode Reverse Recovery Charge				180	270	nC
Reverse Recovery Fall Time	t <sub>a</sub>	i <sub>F</sub> = -4 A, αί/αι = 100 A/μs, 1 <sub>J</sub> = 25 °C		45		nc
Reverse Recovery Rise Time	t <sub>b</sub>	t <sub>b</sub>		20		ns

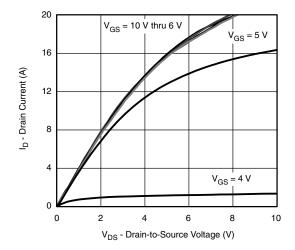
#### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

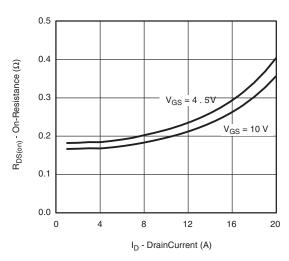
a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

b. Guaranteed by design, not subject to production testing.

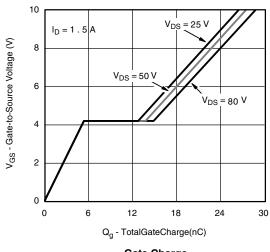




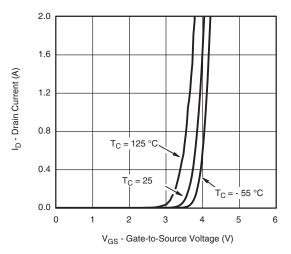
### **Output Characteristics**



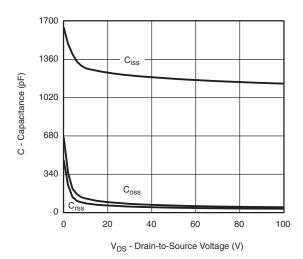
On-Resistance vs. Drain Current and Gate Voltage



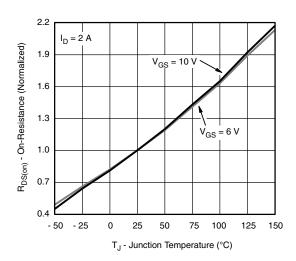
**Gate Charge** 



**Transfer Characteristics** 

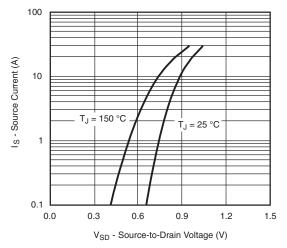


Capacitance

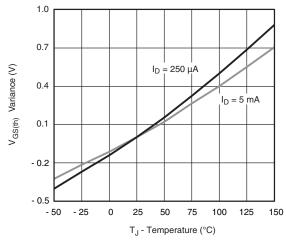


On-Resistance vs. Junction Temperature

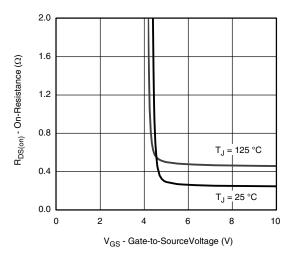




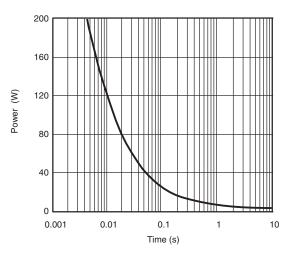
#### Source-Drain Diode Forward Voltage



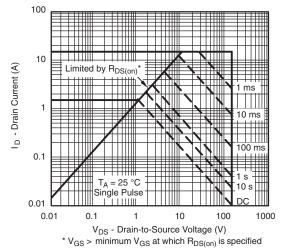
**Threshold Voltage** 



On-Resistance vs. Gate-to-Source Voltage

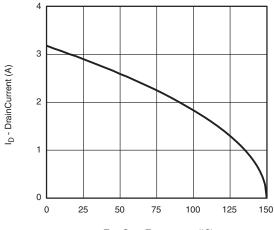


Single Pulse Power, Junction-to-Ambient



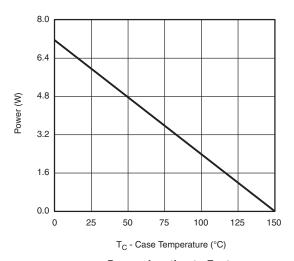
Safe Operating Area, Junction-to-Ambient



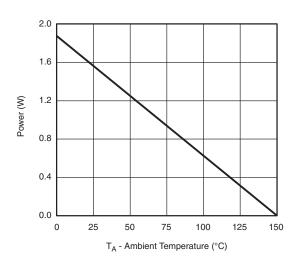


T<sub>C</sub> - Case Temperature (°C)

#### **Current Derating\***



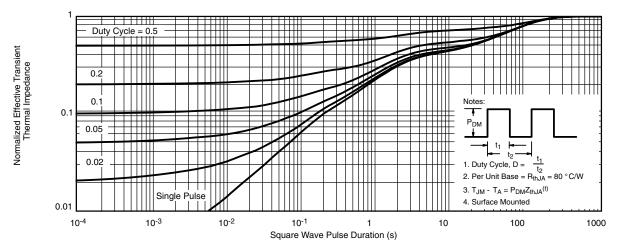




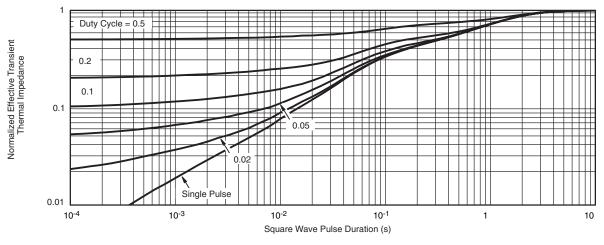
Power, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





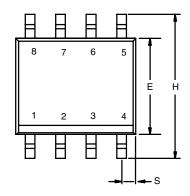
Normalized Thermal Transient Impedance, Junction-to-Ambient

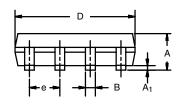


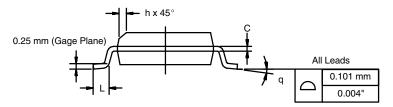
Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







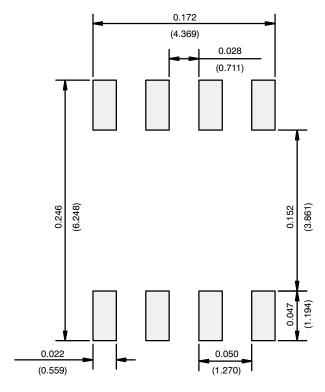
	MILLIM	IETERS	INCHES		
DIM	Min	Max	Min	Max	
Α	1.35	1.75	0.053	0.069	
A <sub>1</sub>	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
Е	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C 06527 Pay L 11 San 06					

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498



## **RECOMMENDED MINIMUM PADS FOR SO-8**



Recommended Minimum Pads Dimensions in Inches/(mm)



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DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B DMN1006UCA6-7 DMN16M9UCA6-7
STF5N65M6 IRF40H233XTMA1 STU5N65M6 DMN6022SSD-13 DMN13M9UCA6-7 DMTH10H4M6SPS-13 DMN2990UFB-7B
IPB80P04P405ATMA2 2N7002W-G MCAC30N06Y-TP MCQ7328-TP NTMC083NP10M5L NVMFS2D3P04M8LT1G BXP7N65D
BXP4N65F AOL1454G WMJ80N60C4 BXP2N20L BXP2N65D BXT1150N10J BXT1700P06M TSM60NB380CP ROG RQ7L055BGTCR
DMNH15H110SK3-13 SLF10N65ABV2 BSO203SP BSO211P